

Notice of References Cited

Application/Control No.

10/577,404

Applicant(s)/Patent Under
Reexamination
MINUTH ET AL.

Examiner

Patrick D. Lynch

Art Unit

3636

Page 1 of 2

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,550,523 A	12-1970	SEGAL IRVING	454/120
*	B	US-3,770,318 A	11-1973	Fenton, Sydney Desmond	297/452.47
*	C	US-4,043,544 A	08-1977	Ismer, Walter	267/83
*	D	US-4,847,933 A	07-1989	Bedford, Peter H.	5/652.2
*	E	US-5,597,200 A	01-1997	Gregory et al.	297/180.13
*	F	US-5,921,100 A	07-1999	Yoshinori et al.	62/244
*	G	US-6,059,018 A	05-2000	Yoshinori et al.	165/42
*	H	US-6,062,641 A	05-2000	Suzuki et al.	297/180.1
*	I	US-6,179,706 B1	01-2001	Yoshinori et al.	454/120
*	J	US-6,481,801 B1	11-2002	Schmale, Gerhard	297/452.27
*	K	US-6,578,910 B2	06-2003	Andersson et al.	297/180.11
*	L	US-2003/0230913 A1	12-2003	Buss et al.	297/180.14
*	M	US-6,685,553 B2	02-2004	Aoki, Shinji	454/120

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	W					
	X					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 10/577,404		Applicant(s)/Patent Under Reexamination MINUTH ET AL.	
	Examiner Patrick D. Lynch		Art Unit 3636	Page 2 of 2

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0189061 A1	09-2004	Hartwich et al.	297/180.14
*	B	US-6,848,742 B1	02-2005	Aoki et al.	297/180.14
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	V				
	W				
	X				

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.